IN THE UNITED STATES PATENT AND TRADEMARK OFFICE fi re patent ap re patent application of: MB Docket No. 1890-0031 Examiner: To be assigned Application No. 10/750,226 Group Art Unit: To be assigned Filed: December 31, 2003 For: Piezoelectric Resonator Apparatus with Acoustic Reflector) I hereby certify that this correspondence is being deposited with the United States Postal Service as first class mail in an envelope addressed to: Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450 on April 12, 2004 (Date of deposit) James D. Wood Name of person mailing Document or fee

## **INFORMATION DISCLOSURE STATEMENT**

April 12, 2004

Date of Signature

Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, Applicant hereby discloses the following references, copies of which are enclosed, regarding the above-identified patent application.

## **Patent References**

<u>Issue</u> Date	<u>Inventor</u>	U.S. Patent No.
September 4, 1979	Benes et al.	4,166,967
October 13, 1998	Lakin	5,821,833
July 11, 2000	Panasik	6,087,198
July 11,	Panasik	6,087,198

## **Articles**

- 1) Lakin, K. M. et al., "Solidly Mounted Resonators and Filters", IEEE Ultrasonics Symposium, 1995, pages 1 – 4, (4 pages).
- 2) Lakin K. M. et al., "High-Q Microwave Acoustic Resonators and Filters", IEEE Transactions on Microwave Theory and Techniques, Volume 41, No. 12, December 1993, pages 2139 – 2146, (8 pages).
- 3) Naik, Rajan S. et al., "Measurements of the Bulk, C-Axis Electromechanical Coupling Constant as a Function of AIN Film Quality," IEEE Transactions on Ultrasonics, Ferroelectrics, and Frequency Control, Volume 47, No. 1, January 2000, pages 292 - 296, (5 pages).
- 4) Mansfeld G. D. et al., "Theory and Numerical Analysis of Bulk Acoustic Wave Multilayer Composite Resonator Structure", IEEE Ultrasonics Symposium, Institute of Radioengineering and Electronics, Russian Academy of Sciences, Moscow, Russia, 1997, pages 891 – 894, (4 pages).
- 5) Li, E. Herbert et al., "Genetic Algorithms for Reflective Filters Design", IEEE, 2001, pages 9-12, (4 pages).

Documents U.S. 5,821,833 and U.S. 4,166,967, as well as the Article, "Measurements of the Bulk, C-Axis Electromechanical Coupling Constant as a Function of AIN Film Quality" were cited in the International Preliminary Examination Report (copy enclosed) and/or the International Search Report (copy enclosed) in a related PCT patent application number PCT/EP02/06144 filed on June 4, 2002.

Documents U.S. 4,166,967 and U.S. 6,087,198, as well as Articles, "High-Q Microwave Acoustic Resonators and Filters", "Theory and Numerical Analysis of Bulk Acoustic Wave Multilayer Composite Resonator Structure", and "Genetic Algorithms for Reflective Filters Design" were cited in the German patent application number 101 31 129.2-35 filed on July 30, 2001.

It is believed that no fees are due for the consideration of this Information Disclosure Statement. However, the Commissioner is hereby authorized to charge any deficiency or to credit any overpayment to Deposit Account No. 13-0014, but not to include any payment of issue fees.

Respectfully Submitted,

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April 12, 2004

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Attorney for Applicants

Registration No. 43,285

FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT	MMB DOCKET NO. 1890-0031	APPLICATION NO.: 10/750,226		
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			U.S. PAT	ENT DOCUMENTS				
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB-CLASS	FILING DATE	
	AA	4,166,967	September 4, 1979	Benes et al.				
	AB	5,821,833	October 13, 1998	Lakin				
	AC	6,087,198	July 11, 2000	Panasik				
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	AN						Yes No	
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	AP						Yes No	
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	AQ 1 Lakin, K. M. et al., "Solidly Mounted Resonators and Filters", IEEE Ultrasonics Symposium, 1995, pages 1 – 4,							
	AR	1 Lakin K.	(4 pages).  Lakin K. M. et al., "High-Q Microwave Acoustic Resonators and Filters", IEEE Transactions on Microwave Theor and Techniques, Volume 41, No. 12, December 1993, pages 2139 – 2146, (8 pages).					
	AS	1 Naik, Ra AIN Film	Naik, Rajan S. et al., "Measurements of the Bulk, C-Axis Electromechanical Coupling Constant as a Function of AIN Film Quality," IEEE Transactions on Ultrasonics, Ferroelectrics, and Frequency Control, Volume 47, No. 1, January 2000, pages 292 – 296, (5 pages).					
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APPLICANT(S): Aigner et al.

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	AQ	2	Mansfeld G. D. et al., "Theory and Numerical Analysis of Bulk Acoustic Wave Multilayer Composite Resonator Structure", IEEE Ultrasonics Symposium, Institute of Radioengineering and Electronics, Russian Academy of Sciences, Moscow, Russia, 1997, pages 891 – 894, (4 pages).					
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